

Substitute Form PTO-1449 (Modified 7-26-98)		U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 07898-056001	Application No. 09/554,186
<b>Information Disclosure Statement by Applicant</b> (Use several sheets if necessary) <small>(37 CFR 1.98(b))</small>		Applicant Yoshii et al.		
		Filing Date May 9, 2000	Group Art Unit 1631	

U.S. Patent Documents							
Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
AM	AA	5,812,272	9/22/98	King et al.	356	445	
AM	AB	5,677,197	10/14/97	Gordon et al.	436	518	RECEIVED
AM	AC	5,968,728	10/19/99	Perttunen et al.	435	4	
	AD						JAN 31 2001
	AE						TECH CENTER 1600/2900
	AF						
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	AH						
	AI						
	AJ						
	AK						

Foreign Patent Documents or Published Foreign Patent Applications							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
AM	AL	DE 197 31 479 A	8/6/98	Germany			
	AM	EP 0 695 941 A2	2/7/96	European			
	AN	DE 43 10 169 A	9/30/93	Germany			
	AO	WO 96/05488	2/22/96	PCT			
↓	AP	0 665 293 A2	8/2/95	European			

Other Documents (include Author, Title, Date, and Place of Publication)			
Examiner Initial	Desig. ID	Document	
	AQ		
	AR		

Examiner Signature <i>Andrea Marschal</i>	Date Considered <i>9/6/01</i>
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 13452-005001	Application No. 09/554,186
<b>Information Disclosure Statement</b> by Applicant (Use several sheets if necessary)		Applicant Yoshii et al.	
		Filing Date May 9, 2000	Group Art Unit 1643
(37 CFR §1.98(b))			

**U.S. Patent Documents**

Examiner Initial	Desig. ID	Patent Number	Issue Date	Patentee	Class	Subclass	Filing Date If Appropriate
W	AQ	5,736,332	07 APR 1998	Mandek:	—	—	
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	AS						<b>RECEIVED</b>
	AT						JUN 25 2002
	AU						
	AV						TECH CENTER 1600/2900
	AW						
	AX						
	AY						
	AZ						
	AAA						

**Foreign Patent Documents or Published Foreign Patent Applications**

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
	ABB							
	ACC							
	ADD							
	AEE							
	AFF							

**Other Documents (include Author, Title, Date, and Place of Publication)**

Examiner Initial	Desig. ID	Document
	AGG	
	AHH	
	AII	
	AJJ	

Examiner Signature	Date Considered
W	W 6/10/02
EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	